

## SWITCHING REGULATOR APPLICATIONS

### Features

- High Voltage :  $BV_{DSS}=650V$ (Min.)
- Low  $C_{rss}$  :  $C_{rss}=16pF$ (Typ.)
- Low gate charge :  $Q_g=35nC$ (Typ.)
- Low  $R_{DS(on)}$  :  $R_{DS(on)}=0.85\Omega$ (Max.)

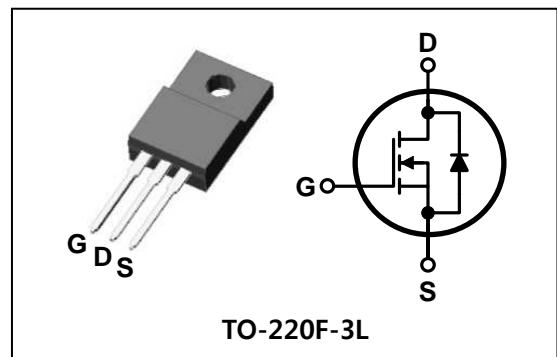
### Ordering Information

Type No.	Marking	Package Code
SMK0965F	SMK0965	TO-220F-3L
SMK0965F (HF)	SMK0965	TO-220F-3L

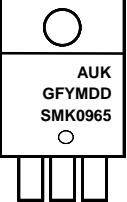
\* SMK0965F : Pb Free Product

\* SMK0965F (HF) : Halogen Free Product

### PIN Connection



### Marking Diagram

	Column 1 : Manufacturer Column 2 : Production Information e.g.) GFYMDD - G : Option Code (H : Halogen Free) - F : Factory Management Code - YMDD : Date Code (Year, Month, Date) Column 3 : Device Code
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### Absolute maximum ratings ( $T_c=25^\circ C$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit
Drain-source voltage	$V_{DSS}$	650	V
Gate-source voltage	$V_{GSS}$	$\pm 30$	V
Drain current (DC) *	$I_D$	$T_c=25^\circ C$	A
		$T_c=100^\circ C$	A
Drain current (Pulsed) *	$I_{DM}$	36	A
Power dissipation	$P_D$	40	W
Avalanche current (Single) ②	$I_{AS}$	9	A
Single pulsed avalanche energy ②	$E_{AS}$	250	mJ
Avalanche current (Repetitive) ①	$I_{AR}$	9	A
Repetitive avalanche energy ①	$E_{AR}$	11.6	mJ
Junction temperature	$T_J$	150	$^\circ C$
Storage temperature range	$T_{stg}$	-55~150	

\* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max.	Unit
Thermal resistance	$R_{th(J-C)}$	-	3.1	$^\circ C/W$
	$R_{th(J-A)}$	-	62.5	

## Electrical Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	$\text{BV}_{\text{DSS}}$	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	650	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=250\mu\text{A}, V_{DS}=V_{GS}$	2.0	-	4.0	V
Drain-source cut-off current	$I_{\text{DSS}}$	$V_{DS}=650\text{V}, V_{GS}=0\text{V}$	-	-	1	$\mu\text{A}$
Gate leakage current	$I_{\text{GSS}}$	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	-	-	$\pm 100$	nA
Drain-source on-resistance <sup>(4)</sup>	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=4.5\text{A}$	-	0.72	0.85	$\Omega$
Forward transfer conductance <sup>(4)</sup>	$g_{fs}$	$V_{DS}=10\text{V}, I_D=4.5\text{A}$	-	11	-	S
Input capacitance	$C_{iss}$	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$ $f=1\text{ MHz}$	-	2040	2550	pF
Output capacitance	$C_{oss}$		-	153	192	
Reverse transfer capacitance	$C_{rss}$		-	16	20	
Turn-on delay time	$t_{d(\text{on})}$	$V_{DD}=300\text{V}, I_D=9\text{A}$ $R_G=25\Omega$	-	23	-	ns
Rise time	$t_r$		-	69	-	
Turn-off delay time	$t_{d(\text{off})}$		-	144	-	
Fall time	$t_f$		-	77	-	
Total gate charge	$Q_g$	$V_{DS}=520\text{V}, V_{GS}=10\text{V}$ $I_D=9\text{A}$	-	35	57	nC
Gate-source charge	$Q_{gs}$		-	10	-	
Gate-drain charge	$Q_{gd}$		-	9	-	

## Source-Drain Diode Ratings and Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise noted)

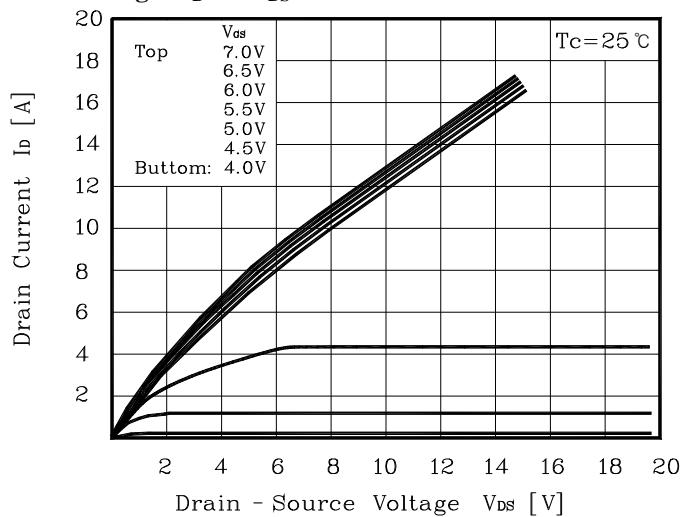
Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	$I_S$	Integral reverse diode in the MOSFET	-	-	9	A
Source current (Pulsed) <sup>(1)</sup>	$I_{SM}$		-	-	36	
Forward voltage <sup>(4)</sup>	$V_{SD}$	$V_{GS}=0\text{V}, I_S=9\text{A}$	-	-	1.4	V
Reverse recovery time	$t_{rr}$	$I_S=9\text{A}, V_{GS}=0\text{V}$ $dI_F/dt=100\text{A}/\mu\text{s}$	-	420	-	ns
Reverse recovery charge	$Q_{rr}$		-	4.2	-	$\mu\text{C}$

Note :

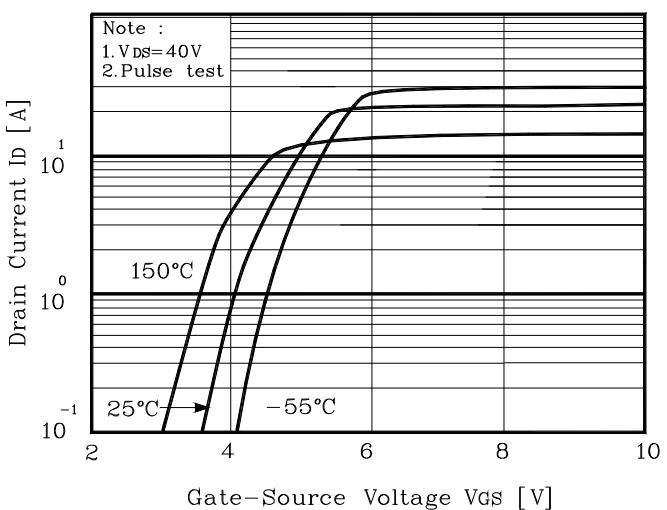
- ① Repetitive rating : Pulse width limited by maximum junction temperature
- ②  $L=5.7\text{mH}, I_{AS}=9\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- ③ Pulse Test : Pulse width  $\leq 300\text{us}$ , Duty cycle  $\leq 2\%$
- ④ Essentially independent of operating temperature

## Electrical Characteristic Curves

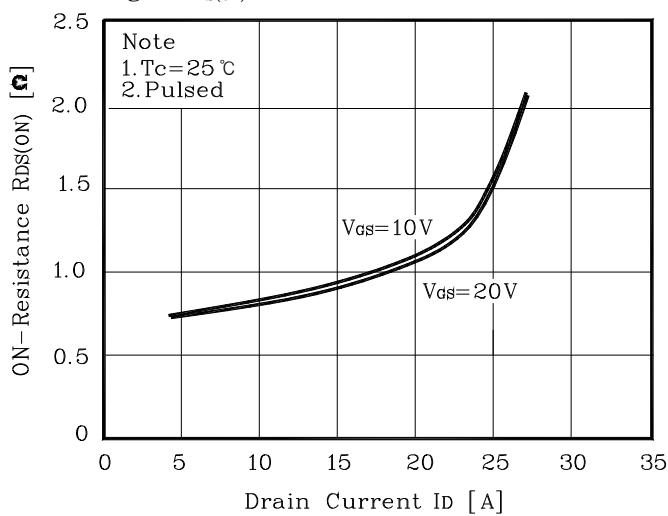
**Fig. 1  $I_D$  -  $V_{DS}$**



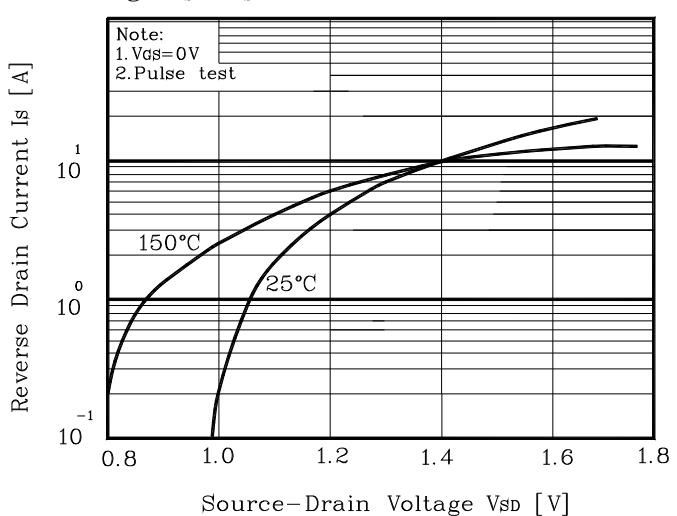
**Fig. 2  $I_D$  -  $V_{GS}$**



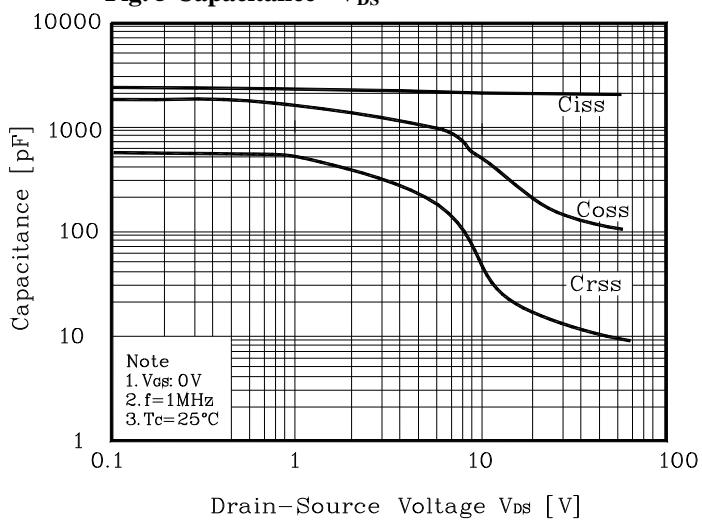
**Fig. 3  $R_{DS(on)}$  -  $I_D$**



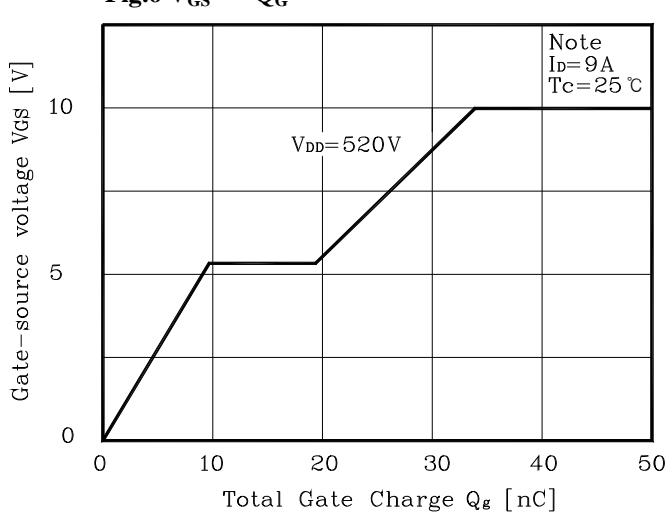
**Fig. 4  $I_S$  -  $V_{SD}$**



**Fig. 5 Capacitance -  $V_{DS}$**

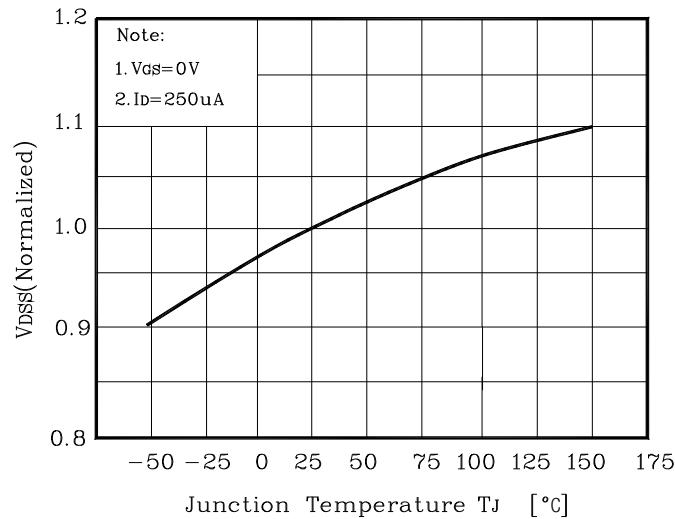


**Fig. 6  $V_{GS}$  -  $Q_G$**

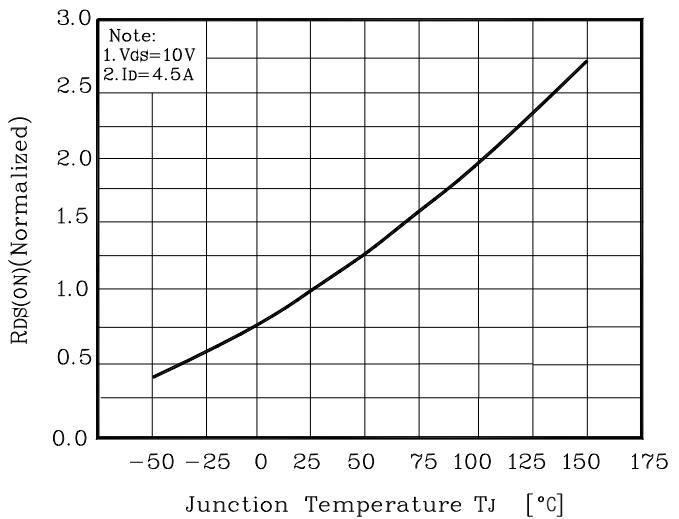


## Electrical Characteristic Curves

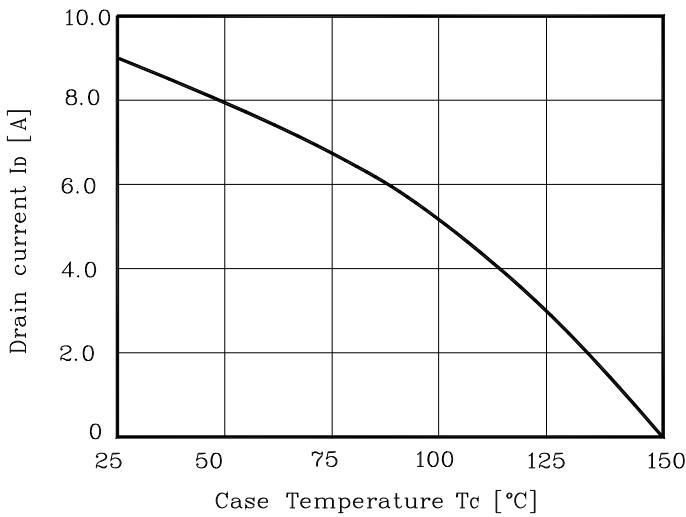
**Fig. 7 V<sub>DSS</sub> - T<sub>J</sub>**



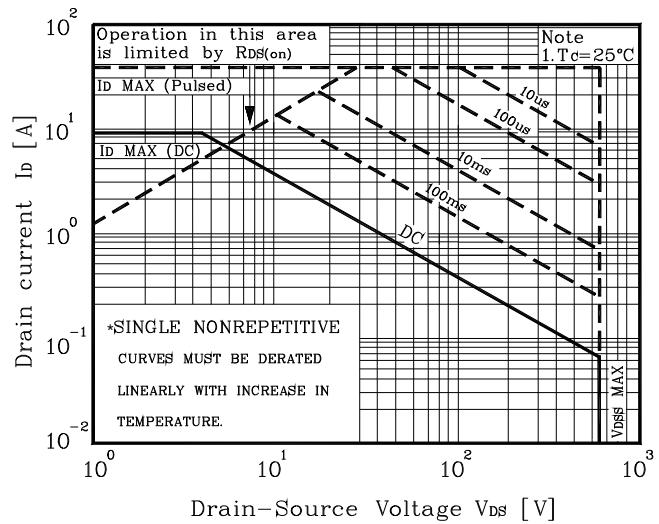
**Fig.8 R<sub>DSS(on)</sub> - T<sub>J</sub>**



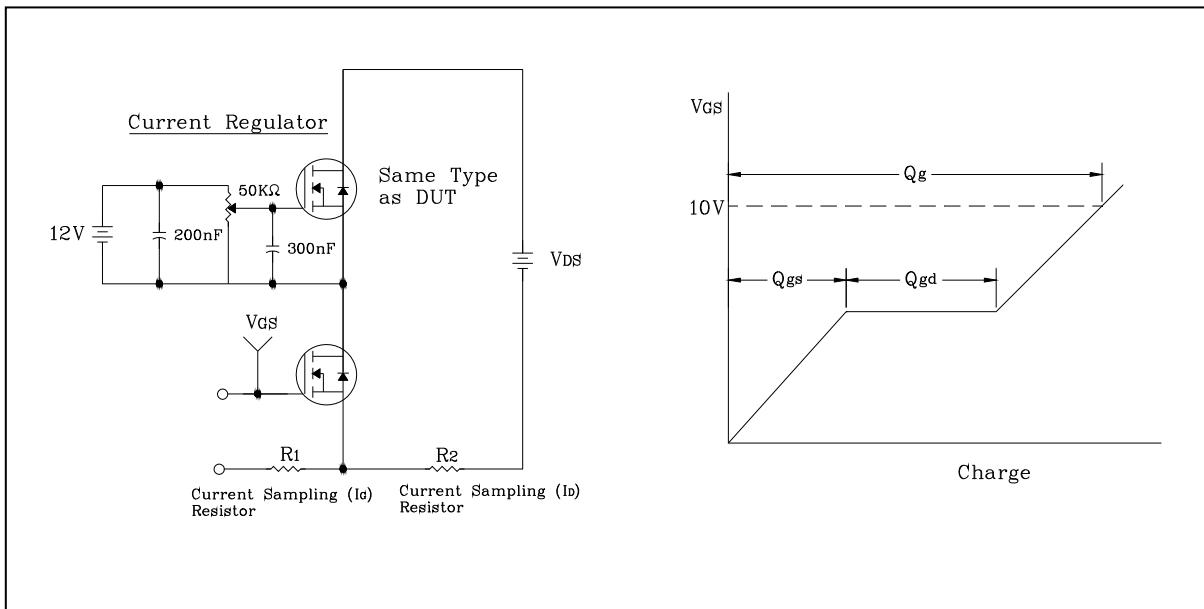
**Fig. 9 I<sub>D</sub> - T<sub>C</sub>**



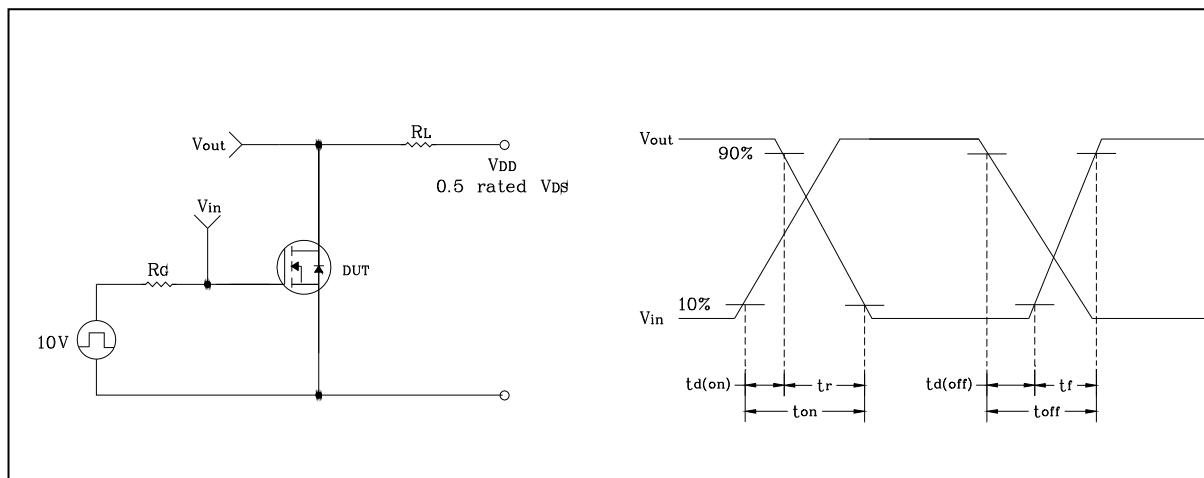
**Fig. 10 Safe Operating Area**



**Fig. 11 Gate Charge Test Circuit & Waveform**



**Fig. 12 Resistive Switching Test Circuit & Waveform**



**Fig. 13 E<sub>AS</sub> Test Circuit & Waveform**

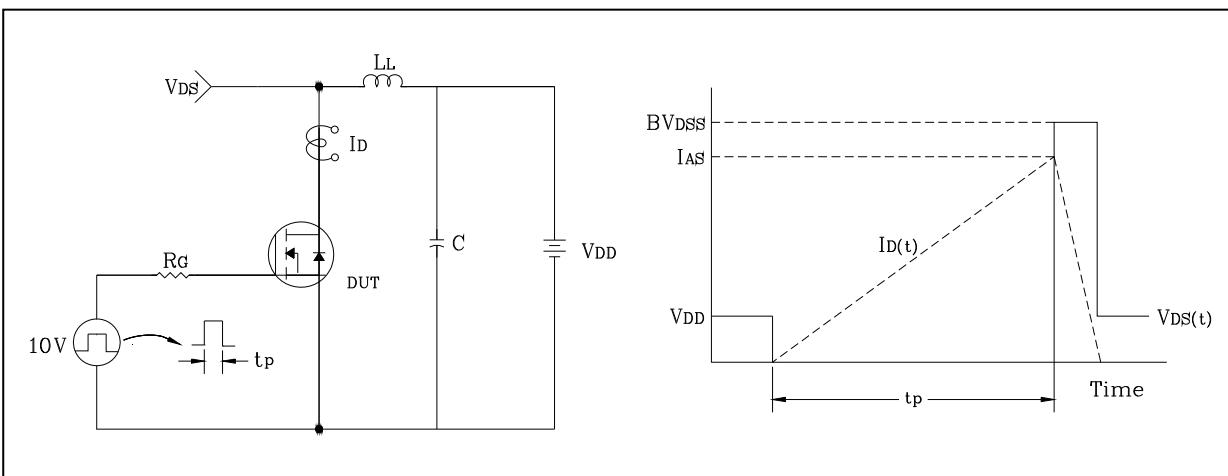
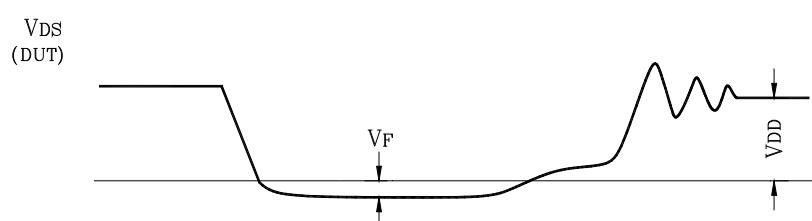
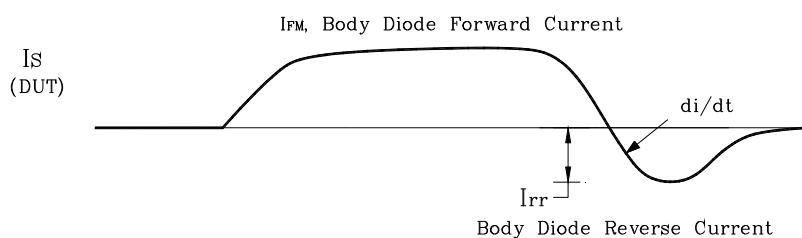
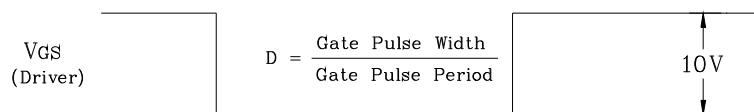
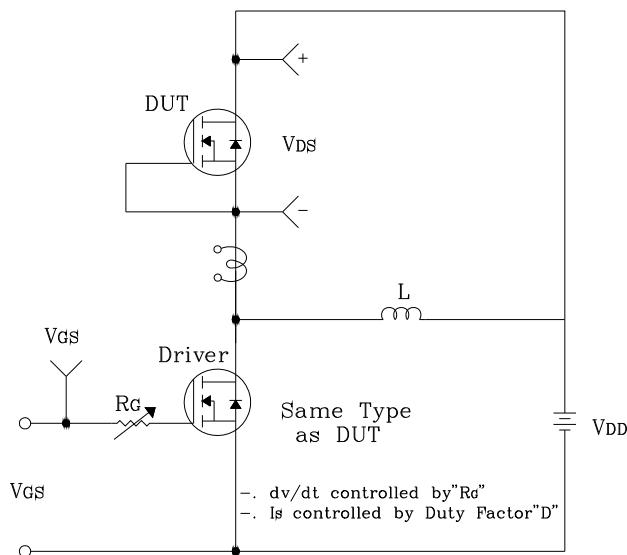
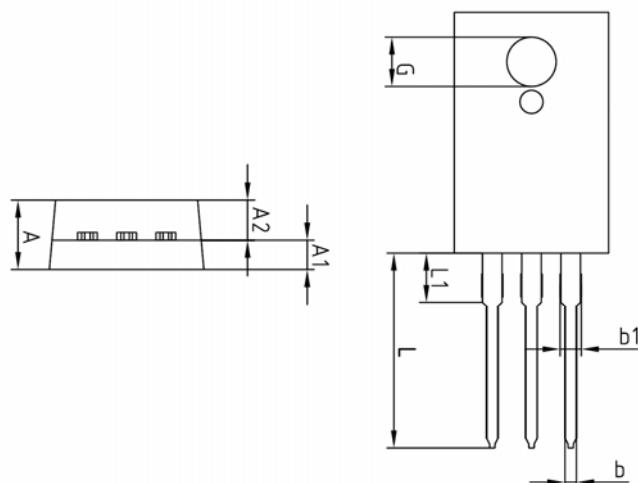
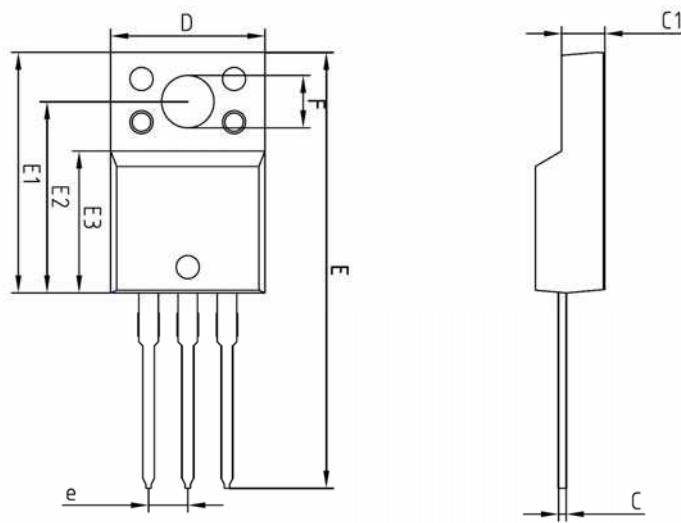


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform



**Outline Dimension**

unit: mm



SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	—	—	4.60	
A1	2.45	2.50	2.55	
A2	1.95	2.00	2.05	
b	0.65	0.75	0.85	
b1	1.07	1.27	1.47	
C	0.40	0.50	0.60	
C1	2.70	2.80	2.90	
D	9.90	10.00	10.10	
E	28.00	—	28.60	
E1	15.50	15.60	15.70	
E2	12.30	12.40	12.50	
E3	9.15	9.20	9.25	
F	3.30	3.40	3.50	
G	3.10	3.20	3.30	
e	2.54 BSC			
L	12.40	—	13.00	
L1	3.46 BSC			

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